


<b><i>Search Notes</i></b>  	<b>Application/Control No.</b>  10565190	<b>Applicant(s)/Patent Under Reexamination</b>  NOMURA, MASAHIRO
	<b>Examiner</b>  HIEP NGUYEN	<b>Art Unit</b>  2816

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
EAST, see attachment	10-08-08	Hn

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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